 Search Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/724,172	TAKEYAMA ET AL.	
Examiner	Art Unit	
TUYEN T NGUYEN	2832	

SEARCHED				
Class	Subclass	Date	Examiner	
336	90-96, 107, 192, 198	5/13/2005	TTN	
123	634-635	5/13/2005	TTN	
update	1 —	8/31/05	TTN	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
Same	as above	8/31/05	TTH		

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
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